

<b>Notice of References Cited</b>	Application/Control No. 10/780,500	Applicant(s)/Patent Under Reexamination OH, BYONG MOK	
	Examiner Enrique L. Santiago	Art Unit 2628	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0081019	06-2002	KATAYAMA et al.	382/154
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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